

Design of low cost, scalable, and high-performance TiS₂ thermoelectric materials via wet ball-milling process

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ABSTRACT

Thermoelectric (TE) materials could provide an efficient means for recovering waste heat energy if a low cost, scalable, and high figure-of-merit material could be fabricated. Here, we report, for the first time, a wet ball-milling method to achieve high-performance two-dimensional (2D) semi-metallic TiS₂ nanoplate-lets. TiO₂ is milled, annealed, and sintered with sulfur under high pressure. The addition of a small amount of sulfur (S) powder during the annealing period prevents sulfur deficiency in the sintered compact, resulting in the formation of a near-stoichiometric TiS₂ composition. The formation of 2D TiS₂ nanoplatelets was confirmed by X-ray diffraction, field emission scanning electron microscopy with energy-dispersive spectroscopy, and X-ray photoelectron spectroscopy. The TE properties were measured in the temperature range of 25–100 °C. Further, we obtain that the prepared TiS₂ has as high figure of merit as 0.35 at 100 °C. Novel wet ball mill processing strategies for the development of high-performance 2D materials such as TiS₂ make it possible to incorporate these materials for scaled-up device fabrication.

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The last decade has seen significant progress in the field of nanoscale thermoelectric materials and their promising application in the energy field. The key factors contributing to the continuing interest in new thermoelectric materials are their potential to efficiently generate electrical power from waste heat without moving parts and serve as a long-lived power source at lower production cost and increased scalability, with no side effects or environmental harm, free from gas emissions. All these factors make them sustainable too.

The efficiency and performance of TE devices are described by the dimensionless figure of merit (ZT) of the TE materials, defined as $ZT = (S^2 \sigma / \kappa) T$, where S is the Seebeck coefficient, σ is the electrical conductivity, κ is the total thermal conductivity, and *T* is the absolute temperature [1–3]. Remarkable progress has been made toward developing high ZT TE materials, largely by tuning electron and phonon transport in the materials by lowering the thermal conductivity (κ) and substantial power factor ($S^2\sigma$) without affecting carrier mobility in the electron crystal region [4, 5]. For the past 50 years, thermoelectric applications with operating temperatures below 300 °C have typically employed bismuth telluride and lead telluride. They are the best-known TE materials in terms of performance with the optimum ZT values around 1. However, tellurides have limited availability and high cost, and, so, alternative materials with lower cost are being widely sought for large-scale applications [6, 7].

Transition metals have emerged as a new class of thermoelectric materials. TiO₂, in particular, has been sought for TE modules, mainly due to its low thermal conductivity. It is also readily available and non-toxic in nature. In addition, as-prepared TiO₂ exhibits *n*-type conductivity, a consequence of its native defects [8]. However, it exhibits intermediate ionicity between fully ionic (Ti⁴⁺ and O²⁻) and covalent bond characteristics, and the asperous estimate indicates a charge of about + 2 on Ti and -1 on O; the electron density of oxygen in TiO₂ is lower than that of the aforementioned ionic crystals [9, 10]. Crucially, such defects are formed by ejecting oxygen from the lattice of TiO₂ followed by the migration of dopant elements [11, 12].

As mentioned earlier, to understand the migration of defects in TiO_2 , previous reports have suggested

several possible mechanisms: (1) that the surface defects of TiO_2 nanoparticles can migrate more easily than bulk defects; (2) that an increase in interstitial defects occurs due to the formation of surface vacancies induced by reduction of the Ti–Ti interlayer distance; and (3) that diffusion defects occur easily along the *c* axis on the O site. The surface vacancies tend to lose oxygen and are relatively easier to generate and compare to Ti interstitials. The defect formation and migration energies can be achieved via heat treatment under a reducing atmosphere [13–15].

At the same time, two-dimensional (2D) transition metal dichalcogenide (TMDC) sulfide materials offer several advantages. They are environmental benign, have low toxicity, low cost, and mechanical flexibility, and they are abundant. Among them, TiS_2 has demonstrated significant progress as a substitute TE material. Its power factor values are close to those of bismuth telluride in the *n*-type TE community [16-19]. For example, Imai et al. [20] revealed an exceptional thermopower value for TiS₂, with a single crystal Seebeck coefficient of about $-250 \ \mu V \ K^{-1}$ at 300 K; *n*-type behavior and a relatively low resistivity of about 1.7 m Ω cm at 300 K. Despite this, the compound went largely unnoticed in the following years, until recently a few publications on this layered 2D structure reported that TiS_2 has great potential as a TE material at low and medium temperatures.

Bourgès et al. [21] widely studied the formation of TiS₂ via mechanical milling utilizing bulk TiS₂, and they obtained a low crystallite grain size according to the Debye-Callaway model. A low crystallite size leads to a structural level reduction in thermal conductivity. The reduction in the mean free path of phonons and an increase in grain boundary scattering led to a slight improvement in ZT, up to 0.3 at 700 K. Ohta et al. [22] optimized the synthesis parameter to form TiS₂ via sulfurization of TiO₂ with CS_2 gas. The prepared TiS_2 -sintered compacts with near-stoichiometric and titanium-rich compositions were measured along the directions perpendicular (in-plane) and parallel (out-plane) to the pressure applied, within the temperature range of 300–723 K. The highest ZT of 0.34 at 663 K was observed in the in-plane direction. Barbier et al. [23] described the intercalation of Ag cations in the van der Waals gap of stage 1- and stage 2-based TiS₂ structures, which remarkably reduced the lattice thermal conductivity through structural disorder. To tune the carrier concentration and to enhance the power factor in the specific temperature range, the intercalated silver provides additional carriers through charge transfer and ZT of 0.45 was achieved at 700 K.

Unfortunately, an overview of TiS_2 composed of light elements found that it was unfavorable for phonon scattering, and a thermal conductivity of around 4 Wm⁻¹ K⁻¹ was typically observed at room temperature in pristine single crystals or bulk materials [24]. This motivated the present work to develop a strategy of synthesis of an *n*-type TiS₂ compound which offers an enormous reduction in thermal conductivity with enhanced ZT value, while maintaining high electrical performance.

To address all these advantages discussed above, the present study aimed to determine the efficiency of wet ball-milled TiO_2 and/or S toward abatement in the liquid phase to form TiS_2 . We examined the bonding of sulfur and the formation of TiS_2 aggregates on the oxide surface. The mechanism of TiS_2 formation could possibly involve the migration of O vacancies or Ti interstitials from the surface of the oxide, which then play a role in the generation of TiS_2 . This approach is attractive, since the TiO_2 precursor could potentially enable large yield, opening the possibility of large-scale production of TE devices.

2 Materials and methods

All the chemicals were purchased from Sigma-Aldrich with 99% purity. The initial precursor was commercial TiO₂-P25 and sulfur with tetrahydrofuran (THF) liquid phase was used as a preparatory material. Also, it is important to mention that the chemical stability of the material relies on the formation mechanism and it is affected by both the synthetic and post-synthetic processes.

Figure 1 shows a schematic representation of the TiS_2 preparation. Briefly, calculated amounts of TiO_2 and sulfur (15 g:5 g; 10 g:10 g; 5 g:15 g are named TS1; TS2; TS3) were placed into a ball mill under wet milling conditions using a high energy planetary ball mill (HEBM; Retsch Planetary PM100, Germany). The jar and milling media employed were made of Zirconia. 250 ml zirconia jars were filled with 400 g of zirconia balls (10 mm diameter) as milling media. The ratio between the weight of the balls and the powder

was 20:1, and a speed of 400 rotations per minute was used for a milling time of 24 h, with a regular interval of 3 min for every 1-h milling cycle, at room temperature.

The topotactic transformation of spherical TiO_2 into 2D platelet TiS_2 using the wet milling process with subsequent annealing is schematically shown in Fig. 1.

Among the predetermined ratios of TiO_2 and sulfur combinations, a lower sulfur content causes less interaction and affects the complete formation of the TiS material. We expect that elemental sulfur first reduces TiO_2 to metallic Titanium (Eq. 1). This is followed by the rapid sulfide formation of Ti into TiS (Eq. 2). The overall assumed reaction is, therefore, the reduction/oxidation combination, both facilitated by sulfur (Eq. 3).

$$TiO_2^{4+} + S^0 \to Ti^0 + SO_2^{4+}$$
 (1)

$$Ti^0 + S^0 \to Ti^{2+}S^{2-}$$
 (2)

$$TiO_2 + 2S \to TiS + SO_2. \tag{3}$$

An increase in the sulfur content also causes a detrimental effect, self-assembly induced by the S–S interaction, which restricts the formation of an orderly arranged TiS material. This clearly suggests the need for a delicate balance between TiO_2 and sulfur to form the TiS material. This is the first observed case where deliberately ball milling TiS materials combines both physical and chemical routes into a single step [25]. In this process, sulfur helps to reduce TiO_2 and generate the low-valent metallic titanium species which further interacts with the sulfur to form TiS.

After milling, the light-gray powder (TiS) was finely ground and subsequently annealed at 300 °C for 3 h. The formed TiS was pyrolyzed with 0.2 mol equivalent of elemental sulfur to form TiS₂. The material was allowed to cool down to room temperature naturally. Then, to achieve an oriented compact with a highly sintered density, we performed inductive hot pressing at 200 °C for 10 min. The final dimensions of each pellet were around 12 mm in diameter and 5 mm in thickness. A dense formation of TiS₂ nanoplatelets was observed and further characterized.

The phase constitution and structural properties of the samples were determined by X-ray diffraction



Fig. 1 Materialization mechanism of TiO₂ to TiS₂

analysis. The microstructure and elemental analysis were examined using a field emission secondary electron microscope equipped with an energy-dispersive spectroscopy (EDS). The bonding state of titanium to sulfur in the prepared samples was investigated by X-ray photoelectron spectroscopy. The carrier concentration was determined by Hall Effect measurement with a van der Pauw electrode configuration at room temperature in a constant magnetic field (1 T) and a constant electrical current of 50 mA. The electrical conductivity and Seebeck coefficient were measured using disc-shaped samples in an argon atmosphere from 25 to 100 °C. The thermal conductivity can be calculated using the equation: $\kappa = C_p \times d \times \lambda$, where C_p , d, and λ are specific heat, density, and thermal diffusivity, respectively. The thermal diffusivity was measured by a laser flash method in an argon atmosphere. The specific heat capacity was measured by differential scanning calorimeter. The density measurement was carried out by a He Gas Pycnometer.

3 Results and discussion

The XRD patterns of the as-purchased $P25-TiO_2$ attributed to an anatase–rutile phase with the surface OH density [26]. Sulfur will react with the functional group and absorb water molecules, which results in the formation of H₂S gas and favors the formation of Ti–S groups [22]. During wet ball milling, the mechanical activation energy will break the partial

surface layer of Ti–O bonds and a low oxygen atmosphere will lead to oxygen vacancies. Since oxygen does not favor, increasing the milling time has a significant effect on the phase transformation, while the milling speed and the powder to ball ratio are the critical factors [15].

In Fig. 2i, the XRD diffraction pattern of TS1 prepared by wet ball milling shows the presence of sharp diffraction peaks which match the standard diffraction pattern of TiS (JCPDS No. 74-0139), without any detectable peaks of impurities. The diffraction peaks obtained at 20.15°, 30.94° , 38.61° , 41.89° , 51.81° , 54.70° , and 57.86° correspond to the (006), (012), (107), (018), (0015), (113), and (116) planes of the TiS with a space group of R-3 m (166). As in the case of TS2 & TS3, it indicates Ti₂(SO₄)₃ which matches JCPDS No. 83-6405 [27, 28].

The chemical binding energies of the as-synthesized TiS and Ti₂(SO₄)₃ were further evaluated by XPS analysis. As shown in Fig. 2ii, there were two strong Ti 2p peaks at 464.4 and 458.1 for TS1, 464.2 and 458.4 for TS2, and 464.2 and 458.5 for TS3, respectively, with a spin–orbit doublet splitting of 6.3, 5.8, and 5.7 eV matching closely the characteristics of the Ti peaks in TS1 and Ti³⁺ in TS2 and TS3. The S 2p spectra presented in (b), (c), and (d) are of TS1, TS2, and TS3, respectively. For TS1, the two peaks are assigned to the S $2p_{3/2}$ and $2p_{1/2}$ and S^{2–} and the fitted peak intensity ratio is 2:1, which refers S atoms that react with O sites near defects of the surface leading to TiS composed [29]. S 2p adsorption





Fig. 2 i XRD profile of as-purchased TiO₂, wet ball-milled Ti₂(SO₄)₃ and TiS₂; ii XPS core level spectra of Ti 2p (a) and S 2p (b-d)

in TS2 and TS3 leads to additional sulfur dosing, leading to saturation and S reaction with O bridging on the oxide surface. These contributions may account for the slight formation of $Ti_2(SO_x)_{x-1}$ [30, 31].

The micrographs of the as-received TiO_2 at low / high magnification and the superimposed mapping image in Fig. 3a–c show a spherical shape with an average diameter of 500 nm. A typical EDS mapping shows homogeneous distribution of Ti, O, and C (which appears due to the sample holder). The asprepared wet-milled TS1 (TiS) is shown in Fig. 3d and e. A strong difference in contrast was observed in the recorded SEM images, and the platelets appear with a light contrast, suggesting the presence of heavy elements such as Ti. The dark contrast between the platelets' surface/edge indicates the presence of lighter elements such as S.

The differences in chemical composition mapping are evident between these regions and the platelets are shown in Fig. 3f. The TiS crystallites are about 10 μ m long and 1 μ m thick with a platelet shape, and it is apparent that the Ti region of particles is extremely dark compared with the S region. This is because they are highly oriented. From the TS2 and TS3 shown in Fig. 3g–l, it was found that an excessive amount of sulfur in the solution can probably delay the formation of orderly arranged TiS materials due to the detrimental effect of the S–S interaction [32]. The progressive phase formation of powder samples after the wet milling without (TS1a)/with (TS1a) sulfur environmental annealing is shown in Fig. 4a. It was seen from the XRD profile that there might be two phases found, with the broad and sharp peaks corresponding to the JCPDS cards: 81-0687 and 80-4223 [27, 28]. The TS1sa absence of peak reveals that the effective role of S ions was facilitated by the migration of O vacancies or Ti³⁺ interstitials from the bulk to the surface of the oxide [33].

The morphology images are presented in Fig. 4b and c of the TS1a and TS1sa samples. In the TS1a sample, there is a distinct transformation from the irregular/angular shape of the starting TiS2 into small aggregates with well-organized shapes. The crystal orientation with anisotropic grain growth is mainly governed by the TiS₂ structure which consists of chains or polyhedral layers. Close-packed atomic planes have low surface energy and are more thermodynamically stable [34]. Such planes also tend to be atomically smooth, making growth perpendicular to the plane difficult to nucleate. In addition, the sulfur annealing used in the solid-liquid-vapor reaction, as in the TS1a synthesis, favors the growth of these large plate-like crystallites. Examination of the fractured cross section by SEM revealed a dense structure, which is consistent with the results of EDS mapping (Fig. 4d).



Fig. 3 SEM images and corresponding EDS mapping of TiO₂ (a-c), TS1 (d-f), TS2 (g-i), and TS3 (j-l)

All the samples showed highly degenerated semiconductor behavior in the extrinsic region and *n*-type behavior. The electron carrier concentration increased with annealing temperature and the pelletization process, as shown in Fig. 5a. The as-received TiO_2 acts as an ineffective acceptor and thus the *n*-type conduction is formed [35]. TS1 (as-prepared-TiS), TS1a (annealed TiS), and TS1sa (sulfur annealed TiS) are pellets prepared at room temperature. Similarly, HTS1, HTS1a, and HTS1sa are pellets prepared at 200 °C for 10 min under the uniaxial pressure of 400 MPa. The density of sulfur annealed/sintered is consistently lower than that of TiO_2 . Most of the sulfur atoms, therefore, are expected to take part in the formation of both the surface and grain boundary layers. If all of the sulfur atoms dissolved in the

Fig. 4 Various annealing conditions with/without sulfur annealed (TS1a/ TS1sa) TiS₂ **a** XRD profile, **b**, **c** SEM images, and **d** cross-sectional SEM image with EDS mapping



matrix were removed, the electron concentration would be $3.961 \times 10^{-19} \text{ m}^{-3}$ which agrees well with the actual increased amount.

Based on the results of the sulfur annealed/sintered, we believe that the grain boundary density decreases and the electron carrier concentration increases. Indeed, the electron concentration increased from 1.91×10^{-17} to 3.96×10^{-19} m⁻³ after sulfur annealing for 3 h and reached up to 7.64×10^{19} m⁻³ with the subsequent hot sintering. This rate of increase can also be explained quantitatively by an increase in sulfur atoms dissolved in the matrix during sintering.

The temperature dependence of the electrical transport properties in the TiS_2 sample is shown in Fig. 5b–d. The Seebeck coefficient as a function of temperature is displayed in Fig. 5b. The negative values of Seebeck coefficient indicate that all the samples are *n* type and the major carriers are

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electrons. On the other hand, it shows the typical updown behavior commonly found in 2D materials, which is mainly due to excitation of the minority carriers [36]. This figure suggests that all the samples show a nearly similar temperature-dependent behavior, which is in-line with those reported earlier for similar TiS₂-based material [37].

The Seebeck coefficient shows an increasing trend with increasing temperature due to intrinsic excitation of the charge carriers, which typically coincides with the performance of their bulk counterpart. The decrease in the Seebeck coefficient is attributed to thermal excitation of the charge carriers across the band gap.

In contrast, the Seebeck coefficient value was 3.35×10^{-05} to 6.78×10^{-05} V K⁻¹ for the temperature range of 25–100 °C because the sulfur was annealed with subsequent hot pressing at 200 °C. The electrical conductivity of the samples with respect to

Fig. 5 Transport properties of TiS_2 with (H)/without temperature hot press: a carrier concentration and density, b Seebeck coefficient, c electrical conductivity, and d power factor

the measured temperature is shown in Fig. 5c. All the samples showed highly degenerated semiconductor behavior in the extrinsic region. The stoichiometry ratio of Ti and S significantly influences the electrical transport properties of TiS_2 .

As a whole, the present results show some similarities to those reported for Ag_xTiS_2 [38], where the charge-transfer mechanism was used to account for the observed phenomenon. The electrical conductivity value of HTS1sa is almost constant but with a small hump at 70 °C. This implies that the amount of S decreases slightly at 50 °C and remains almost constant up to 100 °C. It is reasonable to assume here that the valence electrons of the S atoms transfer to the Ti band of the host after intercalation, leading to an increase in electron concentration and enhancement of TiS₂ [39].

The thermoelectric power factor $(S^{2*}\sigma)$ of TiS₂ can be estimated from the *S* and σ values, as shown in Fig. 5d. The sulfur annealed with hot pressing at 200 °C shows a better power factor of 300 μ W K⁻²m at room temperature pressing. The total thermal conductivity κ total shown in Fig. 6a was estimated in the temperature range of 25–100 °C using the formula: κ total = $C_p \times d \times \lambda$, where C_p , d, and λ are specific heat, density, and thermal diffusivity, respectively.

It can be seen that the annealing and sulfur annealing cause a large decrease in total thermal conductivity over the whole temperature range. The lattice thermal conductivity significantly increased when the sample underwent hot pressing. This increase in lattice thermal conductivity could be due to phonon scattering from the intercalated S atoms in the van der Waals gaps [40, 41].

In Fig. 6b, a comparison of the thermal conductivity performance is shown. All the values are measured as dependent on temperature. As can be seen

Fig. 6 TiS₂ with (H)/without temperature hot press. **a** Thermal conductivity of as-prepared and **b** comparative report so far in the thermal conductivity, **c** ZT efficiency of as-prepared and **d** benchmarking result with comparative report so far in ZT efficiency

in the results the wet ball milling shows the lowest values of thermal conductivity. This performance is attributed to an increase in grain boundary scattering due to the decrease in grain size and point defect scattering due to the S atoms.

Figure 6c shows the temperature dependence of the figure-of-merit ZT for TiS_2 . The ZT values of all the samples tended to increase with increasing temperature. However, the ZT value for the annealed TS1sa is slightly lower than that of hot-pressed annealed HTS1sa because of the large decrease in their thermopower, although their resistivity and thermal conductivity decreased considerably [42, 43].

However, ZT of hot-pressed HTS1sa was substantially improved over the whole temperature range under consideration. Evidently, this improvement in the thermoelectric properties of TiS_2 can be attributed to the increase in Seebeck coefficient, resulting from increased carrier concentration due to charge transfer and decrease in lattice thermal conductivity presumably caused by the vibration of S atoms in the van der Waals gaps of the TiS_2 . A benchmark comparison of ZT values with our results as a function of temperature is shown in Fig. 6d.

4 Conclusion

In the past decade, various strategies have been explored to enhance power generation performance by reducing lattice thermal conductivity in TE materials, which consequently increases their ZT performance. The thermoelectric properties of TiS_2 prepared by wet ball milling with a subsequent sulfur annealing and hot press sintering showed a highest ZT of 0.35 at 100 °C. In addition, the transport properties of carrier concentration were also investigated at room temperature. A significant enhancement in the ZT value was observed because of the higher Seebeck coefficient, high electrical conductivity, and relatively low thermal conductivity of 0.1 W K^{-1} m⁻¹.

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